FAIRCHILD

SEMICONDUCTOR ™

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FDS4559

60V Complementary PowerTrench®MOSFET

General Description

This complementary MOSFET device is produced using Fairchild's advanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain low gate charge for superior switching performance.

Applications

- DC/DC converter
- Power management
- LCD backlight inverter

Features

- **Q1**: **N-Channel**

  4.5 A, 60 V $R_{DS(on)}$ = 55 mΩ @ V_{GS} = 10V

  $R_{DS(on)}$ = 75 mΩ @ V_{GS} = 4.5V

- **Q2**: **P-Channel**

  −3.5 A, −60 V $R_{DS(on)}$ = 105 mΩ @ V_{GS} = −10V

  $R_{DS(on)}$ = 135 mΩ @ V_{GS} = −4.5V

SO-8

Pin 1
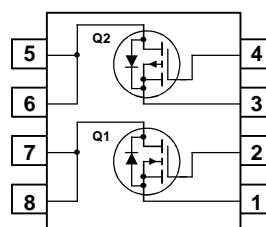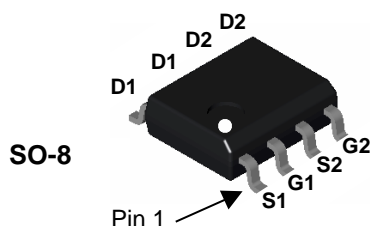
Absolute Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Parameter		Q1	Q2	Units
V_{DSS}	Drain-Source Voltage		60	−60	V
V_{GSS}	Gate-Source Voltage		±20	±20	V
I_D	Drain Current - Continuous	(Note 1a)	4.5	−3.5	A
	- Pulsed		20	−20	
P_D	Power Dissipation for Dual Operation		2		W
	Power Dissipation for Single Operation	(Note 1a)	1.6		
		(Note 1b)	1.2		
		(Note 1c)	1		
T_J, T_{STG}	Operating and Storage Junction Temperature Range		-55 to +175		°C

Thermal Characteristics

$R_{θJA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78		°C/W
$R_{θJC}$	Thermal Resistance, Junction-to-Case	(Note 1)	40		°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDS4559	FDS4559	13"	12mm	2500 units

Electrical Characteristics

T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
Drain-Source Avalanche Ratings (Note 1)							
W_{DSS}	Single Pulse Drain-Source Avalanche Energy	V_{DD} = 30 V, I_D = 4.5 A	Q1			90	mJ
I_{AR}	Maximum Drain-Source Avalanche Current		Q1			4.5	A
Off Characteristics							
BV_{DSS}	Drain-Source Breakdown Voltage	V_{GS} = 0 V, I_D = 250 µA V_{GS} = 0 V, I_D = −250 µA	Q1 Q2	60 −60			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C I_D = −250 µA, Referenced to 25°C	Q1 Q2		58 −49		mV/°C
I_{DSS}	Zero Gate Voltage Drain Current	V_{DS} = 48 V, V_{GS} = 0 V V_{DS} = −48 V, V_{GS} = 0 V	Q1 Q2			1 −1	µA
I_{GSS}	Gate-Body Leakage	V_{GS} = ±20 V, V_{DS} = 0 V V_{GS} = ±20 V, V_{DS} = 0 V	Q1 Q2			±100 ±100	nA
On Characteristics (Note 2)							
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS} = V_{GS}, I_D = 250 µA V_{DS} = V_{GS}, I_D = −250 µA	Q1 Q2	1 −1	2.2 −1.6	3 −3	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C I_D = −250 µA, Referenced to 25°C	Q1 Q2		−5.5 4		mV/°C
$R_{DS(on)}$	Static Drain-Source On-Resistance	V_{GS} = 10 V, I_D = 4.5 A V_{GS} = 10 V, I_D = 4.5 A, T_J = 125°C V_{GS} = 4.5 V, I_D = 4 A	Q1		42 72 55	55 94 75	mΩ
		V_{GS} = −10 V, I_D = −3.5 A V_{GS} = −10 V, I_D = −3.5 A, T_J = 125°C V_{GS} = −4.5 V, I_D = −3.1 A	Q2		82 130 105	105 190 135	
$I_{D(on)}$	On-State Drain Current	V_{GS} = 10 V, V_{DS} = 5 V V_{GS} = −10 V, V_{DS} = −5 V	Q1 Q2	20 −20			A
g_{FS}	Forward Transconductance	V_{DS} = 10 V, I_D = 4.5 A V_{DS} = −5 V, I_D = −3 5 A	Q1 Q2		14 9		S
Dynamic Characteristics							
C_{iss}	Input Capacitance	Q1 V_{DS} = 25 V, V_{GS} = 0 V,	Q1 Q2		650 759		pF
C_{oss}	Output Capacitance	f = 1.0 MHz Q2	Q1 Q2		80 90		pF
C_{rss}	Reverse Transfer Capacitance	V_{DS} = −30 V, V_{GS} = 0 V, f = 1.0 MHz	Q1 Q2		35 39		pF
Switching Characteristics (Note 2)							
$t_{d(on)}$	Turn-On Delay Time	Q1 V_{DD} = 30 V, I_D = 1 A,	Q1 Q2		11 7	20 14	ns
t_r	Turn-On Rise Time	V_{GS} = 10V, R_{GEN} = 6 Ω	Q1 Q2		8 10	18 20	ns
$t_{d(off)}$	Turn-Off Delay Time	Q2 V_{DD} = −30 V, I_D = −1 A,	Q1 Q2		19 19	35 34	ns
t_f	Turn-Off Fall Time	V_{GS} = −10 V, R_{GEN} = 6 Ω	Q1 Q2		6 12	15 22	ns
Q_g	Total Gate Charge	Q1 V_{DS} = 30 V, I_D = 4.5 A, V_{GS} = 10 V	Q1 Q2		12.5 15	18 21	nC
Q_{gs}	Gate-Source Charge	Q2	Q1 Q2		2.4 2.5		nC
Q_{gd}	Gate-Drain Charge	V_{DS} = −30 V, I_D = −3.5 A, V_{GS} = −10V	Q1 Q2		2.6 3.0		nC

## Electrical Characteristics (continued) T_A = 25°C unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Typ	Max	Units
Drain-Source Diode Characteristics and Maximum Ratings							
I_S	Maximum Continuous Drain-Source Diode Forward Current		Q1			1.3	A
			Q2			−1.3	
V_{SD}	Drain-Source Diode Forward Voltage	V_{GS} = 0 V, I_S = 1.3 A (Note 2)	Q1		0.8	1.2	V
		V_{GS} = 0 V, I_S = −1.3 A (Note 2)	Q2		−0.8	−1.2	

Notes:

1. $R_{\theta JA}$ is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. $R_{\theta JC}$ is guaranteed by design while $R_{\theta CA}$ is determined by the user's board design.
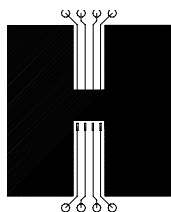
a) 78°C/W when mounted on a 0.5 in^2 pad of 2 oz copper
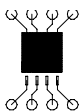
b) 125°C/W when mounted on a .02 in^2 pad of 2 oz copper
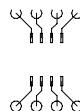
c) 135°C/W when mounted on a minimum pad.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300μs, Duty Cycle < 2.0%

Typical Characteristics: Q2
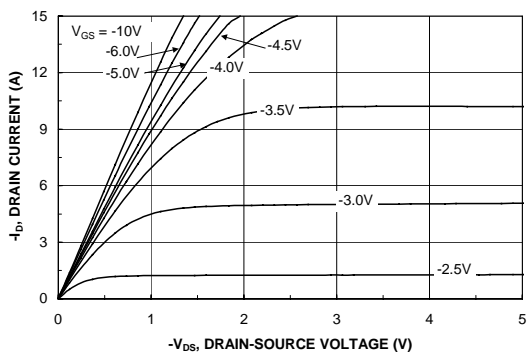
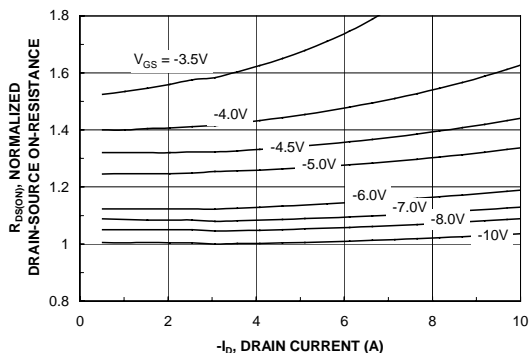Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with
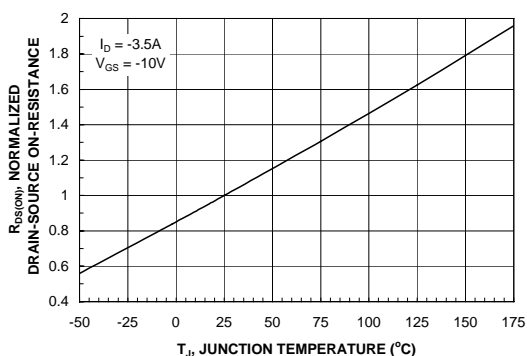Drain Current and Gate Voltage.

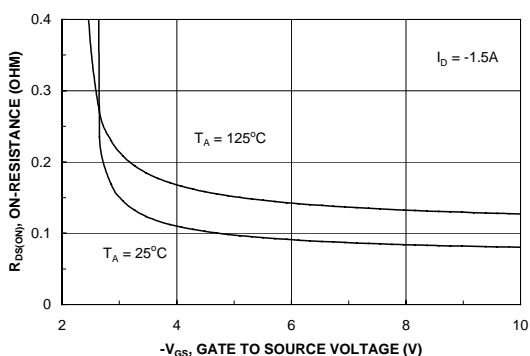Figure 3. On-Resistance Variation with
Temperature.

Figure 4. On-Resistance Variation with
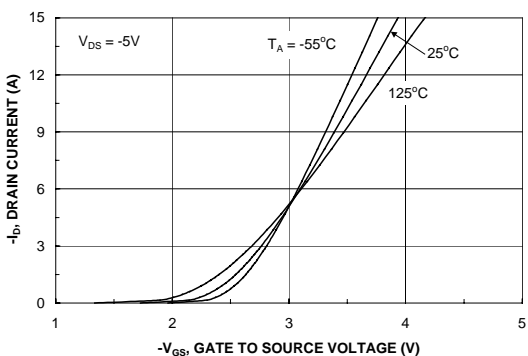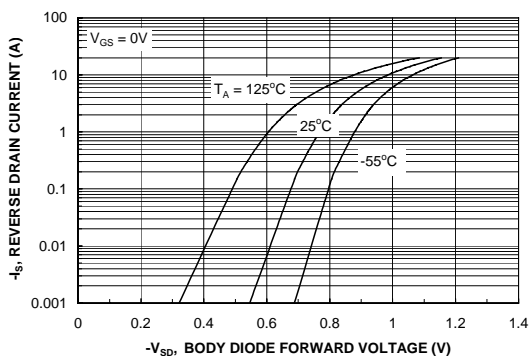Gate-to-Source Voltage.

Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation
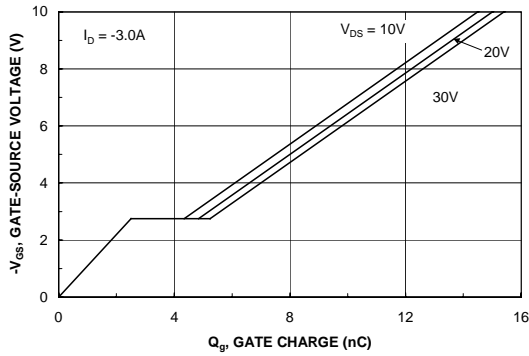with Source Current and Temperature.

Typical Characteristics: Q2

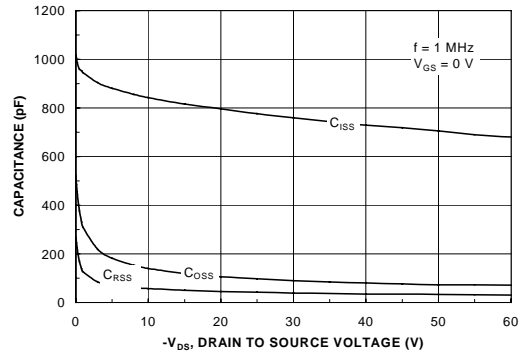Figure 7. Gate Charge Characteristics.

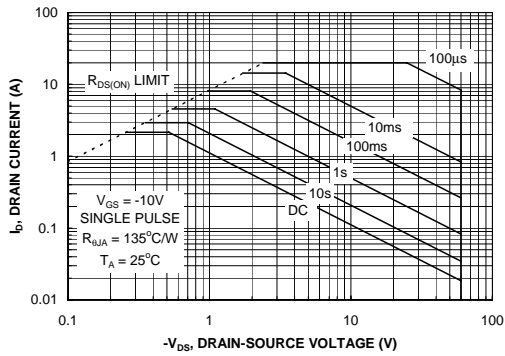Figure 8. Capacitance Characteristics.
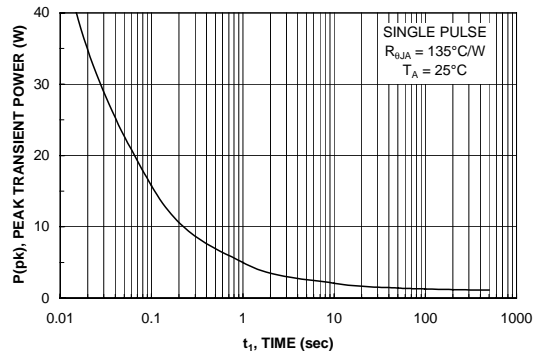

Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum
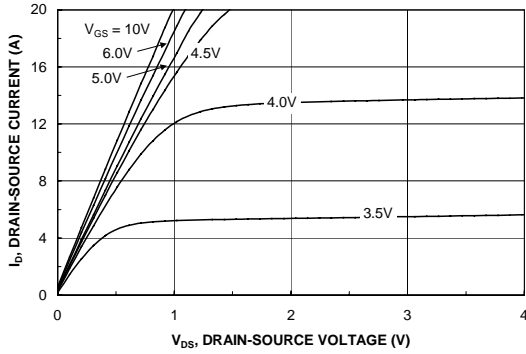Power Dissipation.

Typical Characteristics: Q1
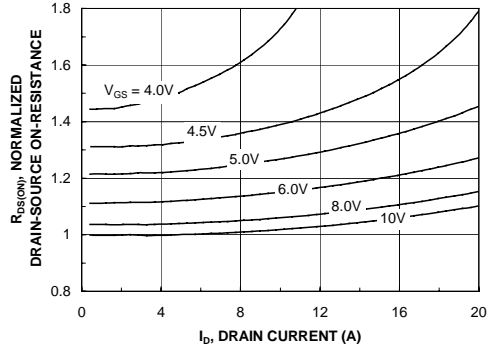

Figure 11. On-Region Characteristics.

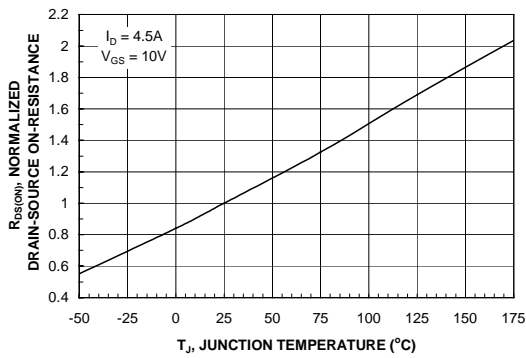**Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.**

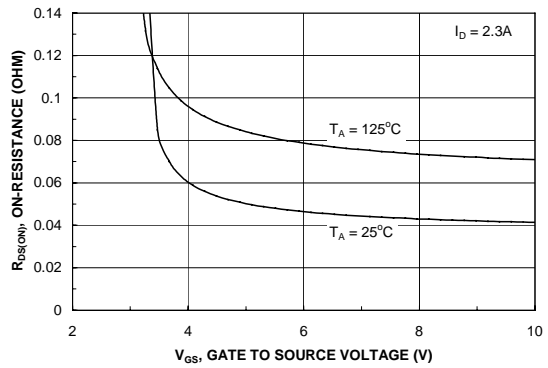**Figure 13. On-Resistance Variation with Temperature.**

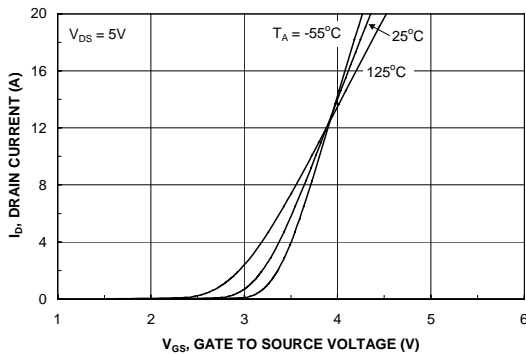**Figure 14. On-Resistance Variation with Gate-to-Source Voltage.**

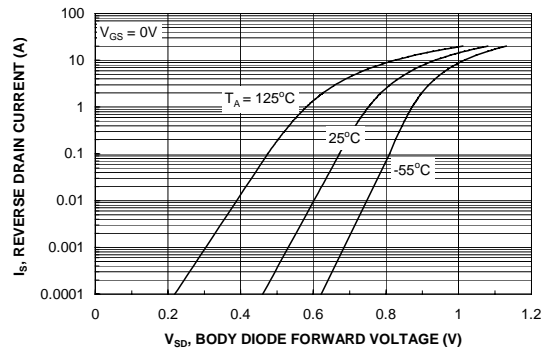**Figure 15. Transfer Characteristics.**

Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: Q1

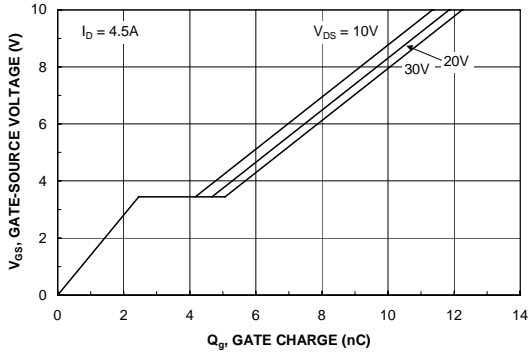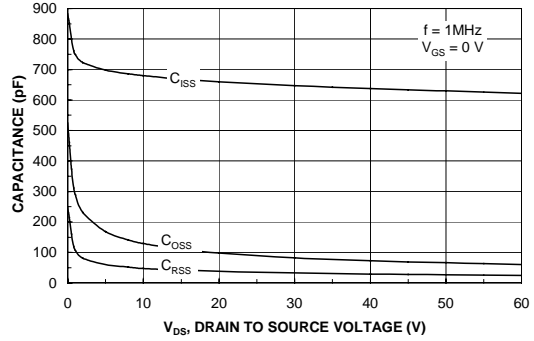**Figure 17. Gate Charge Characteristics.**

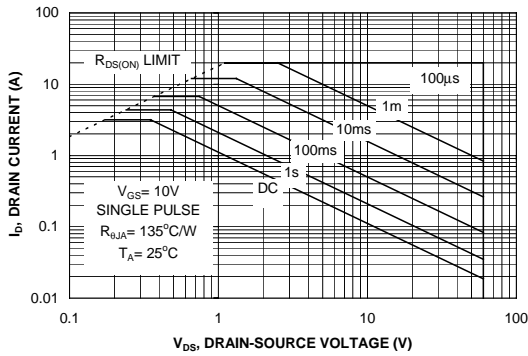**Figure 18. Capacitance Characteristics.**

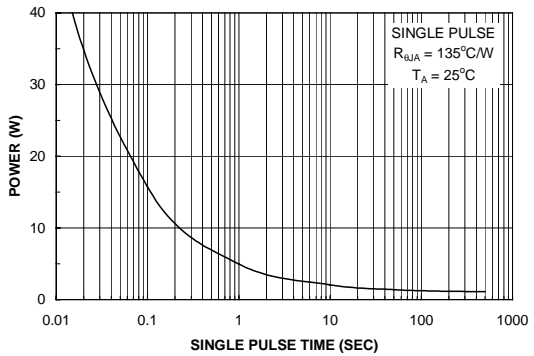**Figure 19. Maximum Safe Operating Area.**

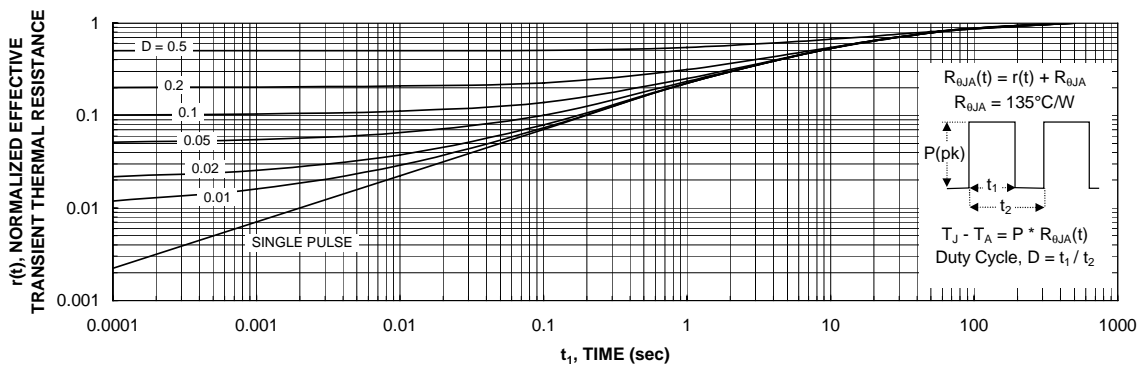**Figure 20. Single Pulse Maximum Power Dissipation.**

Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c.
Transient thermal response will change depending on the circuit board design.

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